FCC REPORT

For LTE

Report No.: CHTEW22090091

Report Verification:

Project No...... SHT2209017701EW

FCC ID.....: 2ASWW-GT30

Applicant: XINCHUANGXIN INTERNATIONAL CO. LTD

YUEN STREET MONGKOK KL

Product Name: Feature phone

Trade Mark CORN

Model No. GT30

Listed Model(s) -

Standard FCC CFR Title 47 Part 2

FCC CFR Title 47 Part 22 FCC CFR Title 47 Part 24

FCC CFR Title 47 Part 27

Date of receipt of test sample...... Sep.07, 2022

Date of testing...... Sep.07, 2022- Sep.21, 2022

Date of issue...... Sep.22, 2022

Result...... Pass

Testing Laboratory Name:

Compiled by

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The test report merely correspond to the test sample.

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1. TEST STANDARDS AND REPORT VERSION

1.1. Applicable Standards

The tests were performed according to following standards:

FCC Rules Part 2: FREQUENCY ALLOCATIONS AND RADIO TREATY MATTERS; GENERAL RULES AND REGULATIONS

FCC Rules Part 22: PUBLIC MOBILE SERVICES

FCC Rules Part 24: PERSONAL COMMUNICATIONS SERVICES

FCC Rules Part 27: MISCELLANEOUS WIRELESS COMMUNICATIONS SERVICES

ANSI C63.26: 2015: American National Standard for Compliance Testing of Transmitters Used in Licensed Radio Services

KDB 971168 D01 Power Meas License Digital Systems v03: MEASUREMENT GUIDANCE FOR CERTIFICATION OF LICENSED DIGITAL TRANSMITTERS

1.2. Report version information

Revision No.	Date of issue	Description
N/A	2022-09-22	Original

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2. TEST DESCRIPTION

Section	Test Item	Section in CFR 47	Result #1	Test Engineer
5.1	Conducted Output Power	Part 2.1046 Part 22.913(a) Part 24.232(c) Part 27.50	Pass	Tiancheng Huang
5.2	Peak-to-Average Ratio	Part 24.232 Part 27.50	Pass	Tiancheng Huang
5.3	99% Occupied Bandwidth & 26 dB Bandwidth	Part 2.1049 Part 22.917(b) Part 24.238(b) Part 27.53	Pass	Tiancheng Huang
5.4	Band Edge	Part 2.1051 Part 22.917 Part 24.238 Part 27.53	Pass	Tiancheng Huang
5.5	Conducted Spurious Emissions	Part 2.1051 Part 22.917 Part 24.238 Part 27.53	Pass	Tiancheng Huang
5.6	Frequency stability vs temperature	Part 2.1055(a)(1)(b) Part 22.355 Part 24.235 Part 27.54	Pass	Tiancheng Huang
5.7	Frequency stability vs voltage	Part 2.1055(d)(1)(2) Part 22.355 Part 24.235 Part 27.54	Pass	Tiancheng Huang
5.8	ERP and EIRP	Part 22.913(a) Part 24.232(b) Part 27.50	Pass	Tiancheng Huang
5.9	Radiated Spurious Emissions	Part 2.1053 Part 22.917 Part 24.238 Part 27.53	Pass	Pan Xie

Note:

#1: The test result does not include measurement uncertainty value

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3. **SUMMARY**

3.1. Client Information

Applicant:	XINCHUANGXIN INTERNATIONAL CO. LTD
Address:	ROOM 605 6/F, FA YUEN COMMERCIAL BUILDING, 75-77 FA YUEN STREET MONGKOK KL
Manufacturer:	Shenzhen Chiteng Technology Co.,LTD
Address:	Second Floor,Area A, Building 4, Huiye Technology Workshop, Guanguang Road, Tangjia Community, Gongming Street, Guangming New District, Shenzhen, Guangdong

3.2. Product Description

Main unit information:	Main unit information:						
Product Name:	Feature phone						
Trade Mark:	CORN						
Model No.:	GT30						
Listed Model(s):	-						
Power supply:	DC 3.7V from Battery						
Hardware version:	ZS583T_MB_V1.1						
Software version:	ZS583T_128160_A18410_GT30_CORN_4G_EnFrPoSp_V01_20220921						
Accessory unit information:							
	Model: FSF-02						
Adapter information:	Input: 100-240Va.c., 50/60Hz, 0.15A						
	Output: 5.0Vd.c., 500mA						

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3.3. Radio Specification Description

Comment On exeting Deads	⊠ FDD Band 2	⊠ FDD Band 4	⊠ FDD Band 5	
Support Operating Band:	⊠ FDD Band 7	⊠ FDD Band 17		
Operating Frequency Range:	Please refer to note #2			
Channel bandwidth:	Please refer to note #3			
Modulation type:	QPSK, 16QAM			
Antenna type:	Interna			
Antenna gain #4:	2.8dbi			

Note:

O \boxtimes : means	that this feat	ure is support	ed:	ans that this	feature is not	supported
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O #2: Operating frequency range is as follow:

LTE Band	Uplink frequency	Downlink frequency
FDD Band 2	1850.7 – 1909.3 MHz	1930.7 – 1989.3 MHz
FDD Band 4	1710.7 – 1754.3 MHz	2110.7 – 2154.3 MHz
FDD Band 5	824.7 - 848.3 MHz	869.7 – 893.3 MHz
FDD Band 7	2502.5 – 2567.5 MHz	2622.5 – 2687.5 MHz
FDD Band 17	706.5 – 713.5 MHz	736.5 – 743.5 MHz

O Supported channel bandwidth is as follow:

LTE Band	1.4MHz	3MHz	5MHz	10MHz	15MHz	20MHz
FDD Band 2	√	√	√	√	√	√
FDD Band 4	√	√	√	√	√	√
FDD Band 5	√	√	√	√	-	-
FDD Band 7	-	-	√	√	√	√
FDD Band 17	-	-	√	√	-	-

^{√:} means that this feature is supported; -: means that this feature is not supported

3.4. Testing Laboratory Information

Laboratory Name	Shenzhen Huatongwei International Inspection Co., Ltd.				
Laboratory Location	1/F, Bldg 3, Hongfa Hi-tech Industrial Park, Genyu Road, Tianliao, Gongming, Shenzhen, China				
Connect information:	Tel: 86-755-26715499 E-mail: cs@szhtw.com.cn http://www.szhtw.com.cn				
Qualifications	Type Accreditation Num				
Qualifications	FCC	762235			

O #4: The antenna gain is provided by the applicant, and the applicant should be responsible for its authenticity, HTW lab has not verified the authenticity of its information

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4. TEST CONFIGURATION

4.1. Test frequency list

FDD Band 2	Test Frequency ID	Bandwidth [MHz]	Nuc	Frequency of Uplink [MHz]	NoL	Frequency of Downlink [MHz]
		1.4	18607	1850.7	607	1930.7
	1	3	18615 18625	1851.5 1852.5	615	1931.5 1932.5
	Low Range	10	18650	1852.5	650	1932.5
	5,000,000,000	15 (1)	18675	1857.5	675	1937.5
	L	20 111	18700	1860	700	1940
	Mid Range	1.4/3/5/10 15 19/20 19	18900	1890	900	1960
		1.4	19193	1909.3	1193	1989.3
	1	3	19185	1908.5	1185	1988.5
	High Range	5 10	19175	1907.5 1905	1175	1987.5 1985
	Colombo j	15 74	19125	1902.5	1125	1982.5
		20 19	19100	1900	1100	1980
	NOTE 1: Bandwidth 1 36:101 [27	or which a relaxat [Clause 7.3) is all		icited UE receivers	ensitivity re	quirement (TS
DD Band 4	Test Frequency ID	Bandwidth [MHz]	N _{DL}	Frequency of Uplink [MHz]	Nos	Frequency of Downlink
			100054	17107	4557	[MHz]
		1.4	19957 19965	1710.7	1957	2110.7
	NUMBER OF THE PROPERTY OF	5	19975	1712.5	1975	2112.5
	Low Range	10	20000	1715	2000	2115
		15	20025	1717.5	2025	2117.5
	164 0-152	20	20050	1720	2050	2120
	Mid Range	1.4/3/5/10/15/20	20175	1732.5	2175 2393	2132.5
		3	20385	1753.5	2385	2153.5
	High Range	5	20375	1752.5	2375	2152.5
	riigh reange	10	20350	1750	2350	2150
		15 20	20325 20300	1747.5 1745	2325 2300	2147.5 2145
DD Band 5	Test Frequency ID	Bandwidth [MHz]	N _{UL}	Frequency of Uplink [MHz]	N _{DL}	Frequency of Downlink [MHz]
		1.4	20407	824.7	2407	969.7
	Low Range	5	20415	825.5 826.5	2415 2425	870.5 871.5
		10 111	20450	829	2450	874
	Mid Range	1.4/3/5	20625	836.5	2525	881.5
	-	1.4	20643	848.3	2643	893.3
	1922/2-25	3	20635	847.5	2635	892.5
	High Range	. 5	20625	846.5	2625	891.5
		to 111	20600	844	2600	889 (rement (TS
	NOTE 1: Bandwidth fo	r which a relaxatio	n of the spec	rued OF receiver Se	mannerith needs	
		or which a relaxatio Clause 7,3) is allo		med OE receiver se	naurny requ	
FDD Band 7		Clause 7,3) is alto Bandwidth [MHz]	Nus	Frequency of Uplink [MHz]	N _{Ds.}	Frequency of Downlink [MHz]
DD Band 7	38.101 (27)	Clause 7.3) is allo Bandwidth [MHz]	Nu. 20775	Frequency of Uplink [MHz] 2502.5	N _{DL}	Frequency of Downlink [MHz] 2622.5
DD Band 7	38.101 (27)	Bandwidth [MHz]	Nut. 20775 20000	Frequency of Uplink [MHz] 2502 5 2505	Nos. 2775 2800	Frequency of Downlink [MHz] 2622 5 2625
DD Band 7	36.101 (27)	Clause 7.3) is allo Bandwidth [MHz]	NuL 20775 20800 20825	Frequency of Uplink [MHz] 2502 5 2506 2507 5	Nos. 2775 2800 2825	Frequency of Downlink [MHz] 2622.5 2625. 2627.5
DD Band 7	36.101 (27)	Bandwidth [MHz] 5 10 15 20 III 570115	Nus. 20775 20800 20825 20850 21100	Frequency of Uplink [MHz] 2502 5 2506 2507 5 2510 2536	Nos. 2775 2800 2825 2850 3100	Frequency of Downlink [MHz] 2622.5 2625.5 2627.5 2630.2655
DD Band 7	38.101 (27) Test Frequency ID Low Range	Bandwidth [MHz] 5 10 15 20 m 5/10/15 20 m 5	Nu. 20775 20800 20825 20850 21100 21425	Frequency of Uplink [MHz] 2502 5 2506 2507 5 2510 2536 2567 5	Nos. 2775 2800 2825 2850 3100 3425	Frequency of Downlink [MHz] 2622.5 2625.5 2627.5 2630 2655.5
DD Band 7	38.101 (27) Test Frequency ID Low Range	Bandwidth [MHz] 5 10 15 20 III 5/10/15 20 III 5 10 10 10 10 10 10 10 10 10 10 10 10 10	Nu. 20775 20800 20825 20850 21100 21425 21400	Frequency of Uplink [MHz] 2502 5 2506 2507 5 2510 2536 2567 5 2666	No. 2775 2800 2825 2850 3100 3425 3400	Frequency of Downlink [MHz] 2622 5 2625 2627 5 2630 2655 2687.5 2689 5
DD Band 7	Test Frequency ID Low Range Mid Range	Bandwidth [MHz] 5 10 15 20 H 5710115 20 H 51	Nut. 20775 20800 20825 20850 21100 21425 21400 21375	Frequency of Uplink [MHz] 2502 5 2506 2507 5 2510 2536 2567 5 2666 2562 5	Nos. 2775 2800 2825 2850 3100 3425 3400 3375	Frequency of Downlink [MHz] 2622.5 2625.5 2627.5 2630.2 2655.2587.5 2685.2
DD Band 7	Test Frequency ID Low Range Mid Range High Range	Bandwidth [MHz] 5 10 15 20 III 5/10/15 20 III 10 15 20 III 5/10/15 20 III 5/10/1	Nu. 20775 20800 20825 20850 21100 21425 21400 21375 21350 n of the spec	Frequency of Uplink [MHz] 2502 5 2506 2507 5 2530 2536 2567 5 2666 2562 5 2562 5	No. 2775 2800 2825 2850 3100 3425 3400 3375 3375	Frequency of Downlink [MHz] 2622 5 2625 2627 5 2630 2655 2685 2682 5 2682 5 2680
FDD Band 7	Test Frequency ID Low Range Mid Range High Range	Bandwidth [MHz] 5 10 15 20 III 579015 20 III 5 10 10 15 20 III 5 10 II 5 20 III 5 10 II 5 20 III 5 10 II 5 II 5	Nu. 20775 20800 20825 20850 21100 21425 21400 21375 21350 n of the spec	Frequency of Uplink [MHz] 2502 5 2506 2507 5 2530 2536 2567 5 2666 2562 5 2562 5	No. 2775 2800 2825 2850 3100 3425 3400 3375 3375	Frequency of Downlink [MHz] 2622 5 2625 2627 5 2630 2655 2685 2682 5 2682 5 2680
FDD Band 7 FDD Band 17	Test Frequency ID Low Range Mid Range High Range NOTE 1: Bandwidth fr. 36.101 [27]	Bandwidth [MHz] 5 10 15 20 III 5/10/15 20 III 5/20 III 5/20 III 5/20 III 5/20 III 5/20 III 5/20 III 6/20 III 5/20 III 8/20 III 6/20 III 6	Nu. 20775 20800 20825 20850 21105 21400 21375 21400 21375 21150 n of the specwed.	Frequency of Uplink [MHz] 2502.5 2506 2507.5 2536 2565 2562.5 2560 UE receiver ser Uplink [MHz]	No. 2775 2800 2825 2850 3100 3425 3400 3375 3350 No. No.	Frequency of Downlink [MHz] 2622 5 2625 2627 5 2630 2655 2682 5 2682 5 2680 retwent (TS
	Test Frequency ID Low Range Mid Range High Range NOTE 1: Bandwidth find 127	Bandwidth [MHz] 5 10 15 20 III 5/10/15 20 III 0 15 20 III 0 15 20 III 0 15 20 III 0 Else Table 10 Clause 7.3) is also Bandwidth [MHz] 5 IV 10 IV	Nu. 20775 20800 20825 20850 21100 21425 21350 and the specwed. Nut. 23755 23750	Frequency of Uplink [MHz] 250.2 5 250.6 2507.5 2510 2567.5 2566 2567.5 2568 2562.5 2560 Frequency of Uplink [MHz] 706.5 709	No. 2775 2890 3100 3425 3350 3350 No. 5755 5780	Frequency of Downlink [MHz] 2622 5 2625 2627 5 2630 2655 26825 26825 26825 7680 Frequency of Downlink [MHz] 736 5 739
	Test Frequency ID Low Range Mid Range High Range NOTE 1: Bandwidth fr. 36.101 [27]	Bandwidth [MHz] 5 10 15 20 Pl 7 Which a relaxatio Clause 7.3) is allow Bandwidth [MHz] 5 Pr 10 Pl 5 Pl 7	Nu. 20775 20800 20825 20850 21100 21425 21400 213750 n of the spec wed.	Frequency of Uplink [MHz] 2502.5 2506 2507.5 2510 2536 2562.5 2560 2562.5 2560 Electron of Uplink [MHz] 706.5 709 710	No. 2775 2900 2825 2850 3100 3425 3490 3375 3350 3375 3350 5750 5780	Frequency of Downlink [MHz] 2622 5 2625 2627 5 2630 2655 2682 5 2682 5 2682 5 7682 5 7682 5 7682 5 7682 7 7 7 7 7 7 7 7 7 7 7 7 7 7 7 7 7 7 7
	Test Frequency ID Low Range Mid Range High Range NOTE 1: Bandwidth fr. 36,101 (27) Test Frequency ID Low Range	Bandwidth [MHz] 5 10 15 20 III 5/10/15 20 III 10 15 10 15 20 III 10 15 10 15 10 15 20 III 10 15 10 15 20 III 10 15 10 15 20 III 10 15 20 III 10 15 20 III 21 21 21 21 21 21 21 21 21 21 21 21 21	Mus. 20775 20800 20825 20850 21100 21425 21400 21375 21350 Nus. Nus. 23755 23780 23790 23825	Frequency of Uplink [MHz] 2502 5 2506 2507 5 2510 2536 2567 5 2666 2562 5 2560 titled UE receiver ser Frequency of Uplink [MHz] 706.5 709 713.5	No. 2775 2890 2825 2850 3100 3425 3400 3375 3350 864/ty required No. 5795 5790 5790 5825	Frequency of Downlink [MHz] 2622 5 2625 2627 5 2630 2655 2687 5 2685 2582 5 2680 Frestnert (TS
	Test Frequency ID Low Range Mid Range High Range NOTE 1: Bandwidth fill 36:101 27 Test Frequency ID Low Range Mid Range High Range High Range NOTE 1: Bandwidth fill Range	Bandwidth [MMz] 5 10 15 20 III 5 10 10 15 20 III 5 10 10 10 10 10 10 10 10 10 10 10 10 10	Nu. 20775 20800 20825 21100 211375 21350 nof the specwed. Nu. 23755 23760 23825 23805	Frequency of Uplink [MHz] 250.2 5 250.6 2507.5 2510 2567.5 2566 2567.5 2566 2562.5 2560 Ifled UE receiver ser Frequency of Uplink [MHz] 706.5 709 710.7 713.5 711	No. 2775 2890 3425 3350 3425 3350 No. 5755 5780 5780 5825 5800	Frequency of Downlink [MHz] 2622 5 2625 2627 5 2630 2655 2687 5 2685 2682 5 2682 5 7890 Frequency of Downlink [MHz] 736 5 749 744 5 741

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4.2. Descriptions of Test mode

Antenna port conducted and radiated test items were performed according to KDB 971168 D01 Power Meas. License Digital Systems and ANSI C63.26 with maximum output power.

Radiated measurements were performed with rotating EUT in different three orthogonal test planes to find the maximum emission.

Test configuration is as follow:

Test Items	Bandwidth	Modulation			
rest items	Danuwium	Modulation	1	Full	
Conducted Output Power	#5	#6	0	0	0
Peak-to-Average Ratio	#5	#6	0	ı	0
99% Occupied Bandwidth & 26 dB Bandwidth	#5	#6	-	ı	0
Band Edge	#5	#6	0	-	0
Conducted Spurious Emission	#5	#6	0	-	
Frequency Stability	#5	#6	-	-	0
ERP and EIRP	#5	#6	0	0	0
Radiated Spurious Emission	#5	#6	0	-	-

Note:

- O #5: Test all kind of bandwith in section 3.3
- O #6: Test all kind of uplink modulation in section 3.3
- O o: means that this configuration is chosen for testing
- O -: means that this configuration is not test.
- O The device is investigatedfrom 30MHz to10 times offundamental signal for radiated spurious emission test under different bandwidth,modulations and RB size/offset in exploratory test. Subsequently, only the worst case emissions(highest bandwidth,QPSK,and 1RB0) are reported.

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4.3. Test sample information

Test item	HTW sample no.		
Conducted test items	Please refer to the description in the appendix report		
Radiated test items	YPHT22090177002		

Note:

Conducted test items: Conducted Output Power, Peak-Average Ratio, 99% Occupied Bandwidth & 26 dB

Bandwidth, Band Edge, Conducted Spurious Emissions, Frequency stability, ERP and

EIRP

Radiated test items: Radiated Spurious Emission

4.4. Support unit used in test configuration and system

The EUT has been associated with peripherals and configuration operated in a manner tended to maximize its emission characteristics in a typical application.

The following peripheral devices and interface cables were connected during the measurement:

Whether support unit is used?						
✓	No					
Item	Equipment	Trade Name	Model No.	Other		
1						
2						

4.5. Testing environmental condition

	VN=Nominal Voltage	DC 3.7V	
Voltage	VL=Lower Voltage	DC 3.4V	
	VH=Higher Voltage	DC 4.2V	
Tomporatura	TN=Normal Temperature	25 °C	
Temperature	Extreme Temperature	From -30°C to + 50°C	
Humidity	30~60 %		
Air Pressure	950-1050 hPa		

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4.6. Statement of the measurement uncertainty

Test Items	MeasurementUncertainty		
Radio frequency	<1GHz: 0.022ppm >1GHz: 0.64ppm		
Conducted output power	0.65 dB		
ERP and EIRP	0.65 dB		
Conducted spurious emission	0.65 dB		
Radiated spurious emission	<1GHz: 2.85dB >1GHz: 3.66dB		
99% Occupied Bandwidth & 26 dB Bandwidth	<1GHz: 0.022ppm >1GHz: 0.64ppm		

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=1.96.

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4.7. Equipments Used during the Test

Used	Test Equipment	Manufacturer	Equipment No.	Model No.	Serial No.	Last Cal. Date (YY-MM-DD)	Next Cal. Date (YY-MM-DD)
•	Signal and spectrum Analyzer	R&S	HTWE0242	FSV40	100048	2022/08/25	2023/08/24
•	Signal & Spectrum Analyzer	R&S	HTWE0262	FSW26	103440	2022/08/25	2023/08/24
•	Spectrum Analyzer	Agilent	HTWE0286	N9020A	MY50510187	2022/08/25	2023/08/24
•	Radio communication tester	R&S	HTWE0287	CMW500	137688-Lv	2022/08/25	2023/08/24
•	Test software	Tonscend	N/A	JS1120	N/A	N/A	N/A

•	Radiated Spurious Emission						
Used	Test Equipment	Manufacturer	Equipment No.	Model No.	Serial No.	Last Cal. Date (YY-MM-DD)	Next Cal. Date (YY-MM-DD)
•	Semi-Anechoic Chamber	Albatross projects	HTWE0122	SAC-3m-01	C11121	2018/09/27	2023/09/26
•	Spectrum Analyzer	R&S	HTWE0098	FSP40	100597	2022/08/25	2023/08/24
•	Loop Antenna	R&S	HTWE0170	HFH2-Z2	100020	2021/04/06	2024/04/05
•	Broadband Horn Antenna	SCHWARZBECK	HTWE0103	BBHA9170	BBHA9170472	2020/04/27	2023/04/26
•	Ultra-Broadband Antenna	SCHWARZBECK	HTWE0123	VULB9163	538	2021/04/06	2024/04/05
•	Horn Antenna	SCHWARZBECK	HTWE0126	9120D	1011	2020/04/01	2023/03/31
•	Pre-amplifier	CD	HTWE0071	PAP-0102	12004	2021/11/05	2022/11/04
•	Broadband Preamplifier	SCHWARZBECK	HTWE0201	BBV 9718	9718-248	2022/02/28	2023/02/27
•	RF Connection Cable	HUBER+SUHNER	HTWE0120-01	6m 18GHz S Serisa	N/A	2022/02/25	2023/02/24
•	RF Connection Cable	HUBER+SUHNER	HTWE0120-02	6m 3GHz RG Serisa	N/A	2022/02/25	2023/02/24
•	RF Connection Cable	HUBER+SUHNER	HTWE0119-05	6m 3GHz RG Serisa	N/A	2022/02/25	2023/02/24
•	RF Connection Cable	HUBER+SUHNER	HTWE0120-04	6m 3GHz RG Serisa	N/A	2022/02/25	2023/02/24
•	EMI Test Software	Audix	N/A	E3	N/A	N/A	N/A

•	Auxiliary Equipment						
Used	Test Equipment	Manufacturer	Equipment No.	Model No.	Serial No.	Last Cal. Date (YY-MM-DD)	Next Cal. Date (YY-MM-DD)
•	Climate chamber	ESPEC	HTWE0254	GPL-2	N/A	2022/08/29	2023/08/28
•	DC Power Supply	Gwinstek	HTWE0274	SPS-2415	GER835793	N/A	N/A

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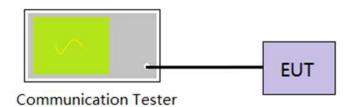
5. TEST CONDITIONS AND RESULTS

5.1. Conducted Output Power

LIMIT

N/A

TEST CONFIGURATION



TEST PROCEDURE

- 1. The EUT output port was connected to communication tester.
- 2. Set EUT at maximum power through communication tester.
- 3. Select lowest, middle, and highest channels for each band and different modulation.
- 4. Measure the maximum burst average power.

TEST MODE:

Please refer to the clause 4.2

TEST RESULTS

Refer to appendix A on the section 8 appendix report

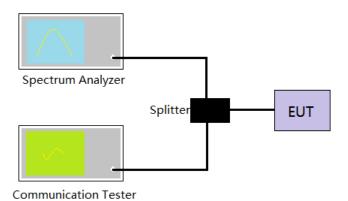
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5.2. Peak-to-Average Ratio

LIMIT

13dB

TEST CONFIGURATION



TEST PROCEDURE

- 1. The EUT was connected to the spectrum analyzer and communication tester via a power splitter
- 2. Set EUT in maximum power output.
- 3. Center Frequency = Carrier frequency, RBW > Emission bandwidth of signal
- 4. The signal analyzer was set to collect one million samples to generate the CCDF curve
- 5. The measurement interval was set depending on the type of signal analyzed.
 - i. For continuous signals (>98% duty cycle), the measurement interval was set to 1ms.
 - ii. For bursttransmissions, the spectrum analyzer is set to use an internal "RF Burst" trigger that issynced with an incoming pulse and the measurement interval is set to less than the durationof the "on time" of one burst to ensure that energy is only captured during a time in whichthetransmitter is operating at maximum power
- 6. Record the maximum PAPR level associated with a probability of 0.1%.

TEST MODE:

Please refer to the clause 4.2

TEST RESULTS

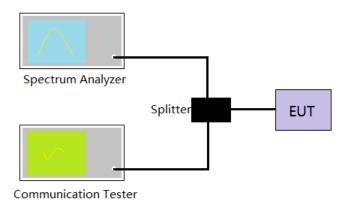
Refer to appendix B on the section 8 appendix report

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5.3. 99% Occupied Bandwidth & 26 dB Bandwidth

LIMIT N/A

TEST CONFIGURATION



TEST PROCEDURE

- 1. The EUT was connected to the spectrum analyzer and communication tester via a power splitter
- 2. Set EUT in maximum power output.
- 3. Spectrum analyzer setting as follow:

Center Frequency= Carrier frequency, RBW=1% to 5% of the anticipated OBW, VBW= 3 * RBW, Detector=Peak,

Trace maximum hold.

4. Record the value of 99% Occupied bandwidth and 26dB bandwidth.

TEST MODE:

Please refer to the clause 4.2

TEST RESULTS

Refer to appendix C on the section 8 appendix report

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5.4. Band Edge

LIMIT

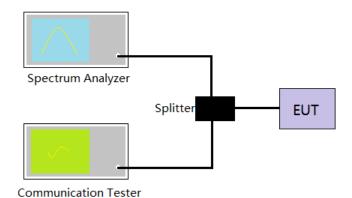
Part 24.238 and Part 22.917 and Part 27.53 specify that the power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least 43 + 10 log(P) dB.

The specification that emissions shall be attenuated below the transmitter power (P) by at least 43 + 10 log (P) dB, translates in the relevant power range (1 to 0.001 W) to -13 dBm. At 1 W the specified minimum attenuation becomes 43 dB and relative to a 30 dBm (1 W) carrier becomes a limit of -13 dBm. At 0.001 W (0 dBm) the minimum attenuation is 13 dB, which again yields a limit of -13 dBm. In this way a translation of the specification from relative to absolute terms is carried out.

LTE Band 7

Part 27.53 m(4) For mobile digital stations, the attenuation factor shall be not less than $40 + 10 \log (P)$ dB on all frequencies between the channel edge and 5 megahertz from the channel edge, $43 + 10 \log (P)$ dB on all frequencies between 5 megahertz and X megahertz from the channel edge, and $55 + 10 \log (P)$ dB on all frequencies more than X megahertz from the channel edge, where X is the greater of 6 megahertz or the actual emission bandwidth as defined in paragraph (m)(6) of this section.

TEST CONFIGURATION



TEST PROCEDURE

- 1. The EUT was connected to the spectrum analyzer and communication tester via a power splitter
- 2. Set EUT in maximum power output.
- 3. The band edges of low and high channels were measured.
- 4. Spectrum analyzer setting as follow:

RBW= no less than 1% of the OBW, VBW =3 * RBW, Sweep time= Auto

5. Record the test plot.

TEST MODE:

Please refer to the clause 4.2

TEST RESULTS

Refer to appendix D on the section 8 appendix report

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5.5. Conducted Spurious Emissions

LIMIT

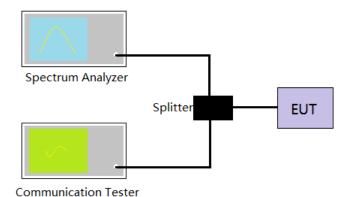
Part 24.238 and Part 22.917 and Part 27.53 specify that the power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least 43 + 10 log(P) dB.

The specification that emissions shall be attenuated below the transmitter power (P) by at least 43 + 10 log (P) dB, translates in the relevant power range (1 to 0.001 W) to -13 dBm. At 1 W the specified minimum attenuation becomes 43 dB and relative to a 30 dBm (1 W) carrier becomes a limit of -13 dBm. At 0.001 W (0 dBm) the minimum attenuation is 13 dB, which again yields a limit of -13 dBm. In this way a translation of the specification from relative to absolute terms is carried out.

LTE Band 7

Part 27.53 m(4) For mobile digital stations, the attenuation factor shall be not less than 40 + 10 log (P) dB on all frequencies between the channel edge and 5 megahertz from the channel edge, 43 + 10 log (P) dB on all frequencies between 5 megahertz and X megahertz from the channel edge, and 55 + 10 log (P) dB on all frequencies more than X megahertz from the channel edge, where X is the greater of 6 megahertz or the actual emission bandwidth as defined in paragraph (m)(6) of this section. In addition, the attenuation factor shall not be less that 43 + 10 log (P) dB on all frequencies between 2490.5 MHz and 2496 MHz and 55 + 10 log (P) dB at or below 2490.5 MHz. Mobile Satellite Service licensees operating on frequencies below 2495 MHz may also submit a documented interference complaint against BRS licensees operating on channel BRS Channel 1 on the same terms and conditions as adjacent channel BRS or EBS licensees. Limit <-25 dBm

TEST CONFIGURATION



TEST PROCEDURE

- 1. The EUT was connected to the spectrum analyzer and communication tester via a power splitter
- 2. Set EUT in maximum power output.
- 3. Spectrum analyzer setting as follow:

Below 1GHz, RBW=100KHz, VBW = 300KHz, Detector=Peak, Sweep time= Auto Above 1GHz, RBW=1MHz, VBW=3MHz, Detector=Peak, Sweep time= Auto Scan frequency range up to 10th harmonic.

4. Record the test plot.

TEST MODE:

Please refer to the clause 4.2

TEST RESULTS

Refer to appendix E on the section 8 appendix report

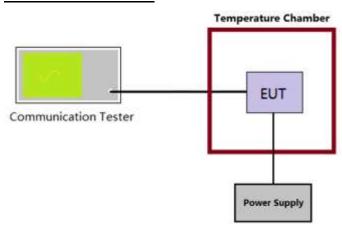
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5.6. Frequency stability VS Temperature measurement

LIMIT

2.5ppm

TEST CONFIGURATION



TEST PROCEDURE

- 1. The equipment under test was connected to an external DC power supply and input rated voltage.
- 2. The EUT output port was connected to communication tester.
- 3. The EUT was placed inside the temperature chamber.
- 4. Turn EUT off and set the chamber temperature to –30°C. After the temperature stabilized for approximately 30 minutes recorded the frequency.
- 5. Repeat step 4 measure with 10°C increased per stage until the highest temperature of +50°C reached.

TEST MODE:

Please refer to the clause 4.2

TEST RESULTS

Refer to appendix F on the section 8 appendix report

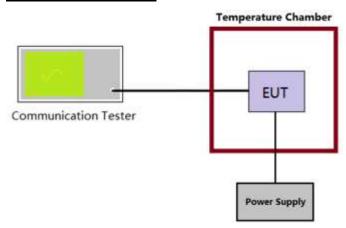
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5.7. Frequency stability VS Voltage measurement

LIMIT

2.5ppm

TEST CONFIGURATION



TEST PROCEDURE

- 1. The equipment under test was connected to an external DC power supply and input rated voltage.
- 2. The EUT output port was connected to communication tester.
- 3. The EUT was placed inside the temperature chamber at 25°C
- 4. The power supply voltage to the EUT was varied ±15% of the nominal value measured at the input to the EUT
- 5. Record the maximum frequency change.

TEST MODE:

Please refer to the clause 4.2

TEST RESULTS

Refer to appendix F on the section 8 appendix report

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5.8. ERP and EIRP

LIMIT

LTE Band 2/7/25/38/41: 2W(33dBm) EIRP

LTE Band 4/66: 1W(30dBm) EIRP LTE Band 5/26: 7W(38.50dBm) ERP

LTE Band 12/13/17/71: 3W(34.77dBm) ERP

TEST PROCEDURE

- 1. According to the power tested in section 5.1, select the maximum power in each mode, and use the following formula to calculate the corresponding ERP/EIRP.
- 2. ERP = conducted power + Gain(dBd)
- 3. EIRP = conducted power + Gain(dBi)

ERP = EIRP - 2.15

TEST RESULTS

□ Passed	☐ Not Applicable
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Refer to appendix G on the section 8 appendix report

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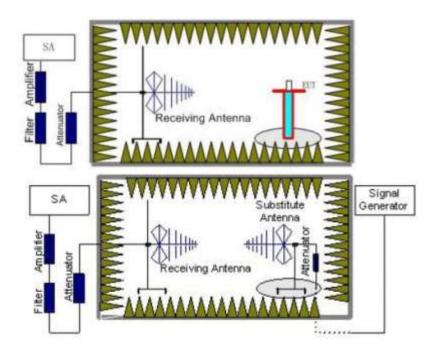
5.9. Radiated Spurious Emission

LIMIT

LTE Band 2/4/5/12/13/17/25/26/66/71: -13dBm;

LTE Band 7/38/41: -25dBm

TEST CONFIGURATION



TEST PROCEDURE

- 1. Place the EUT in the center of the turntable.
 - a) For radiated emissions measurements performed at frequencies less than or equal to 1 GHz, the EUT shall be placed on a RF-transparent table at a nominal height of 80 cm above the reference ground plane
 - b) For radiated measurements performed at frequencies above 1 GHz, the EUT shall be placed on an RF transparent table at a nominal height of 1.5 m above the ground plane.
- 2. Unless the EUT uses an integral antenna, the EUT shall be terminated with a non-radiating transmitter load. In cases where the EUT uses an adjustable antenna, the antenna shall be adjusted through typical positions and lengths to maximize emissions levels.
- 3. The EUT shall be tested while operating on the frequency per manufacturer specification. Set the transmitter to operate in continuous transmit mode.
- Receiver or Spectrum set as follow:

Below 1GHz, RBW=100kHz, VBW=300kHz, Detector=Peak, Sweep time=Auto

Above 1GHz, RBW=1MHz, VBW=3MHz, Detector=Peck, Sweep time=Auto

- 5. Each emission under consideration shall be evaluated:
 - a) Raise and lower the measurement antenna from 1 m to 4 m, as necessary to enable detection of the maximum emission amplitude relative to measurement antenna height.
 - b) Rotate the EUT through 360° to determine the maximum emission level relative to the axial position.
 - c) Return the turntable to the azimuth where the highest emission amplitude level was observed.
 - d) Vary the measurement antenna height again through 1 m to 4 m again to find the height associated with the maximum emission amplitude.
 - e) Record the measured emission amplitude level and frequency
- 6. Repeat step 5 for each emission frequency with the measurement antenna oriented in both the horizontal

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and vertical polarizations to determine the orientation that gives the maximum emissions amplitude.

- Set-up the substitution measurement with the reference point of the substitution antenna located as near
 as possible to where the center of the EUT radiating element was located during the initial EUT
 measurement.
- 8. Maintain the previous measurement instrument settings and test set-up, with the exception that the EUT is removed and replaced by the substitution antenna.
- 9. Connect a signal generator to the substitution antenna; locate the signal generator so as to minimize any potential influences on the measurement results. Set the signal generator to the frequency where emissions are detected, and set an output power level such that the radiated signal can be detected by the measurement instrument, with sufficient dynamic range relative to the noise floor.
- 10. For each emission that was detected and measured in the initial test
 - a) Vary the measurement antenna height between 1 m to 4 m to maximize the received (measured) signal amplitude.
 - b) Adjust the signal generator output power level until the amplitude detected by the measurement instrument equals the amplitude level of the emission previously measured directly in step 5 and step 6.
 - c) Record the output power level of the signal generator when equivalence is achieved in step b).
- 11. Repeat step 8 through step 10 with the measurement antenna oriented in the opposite polarization.
- 12. Calculate the emission power in dBm referenced to a half-wave dipole using the following equation:

Pe = Ps(dBm) - cable loss (dB) + antenna gain (dBd)

where

Pe = equivalent emission power in dBm

Ps = source (signal generator) power in dBm

NOTE—dBd refers to the measured antenna gain in decibels relative to a half-wave dipole.

13. Correct the antenna gain of the substitution antenna if necessary to reference the emission power to a half-wave dipole. When using measurement antennas with the gain specified in dBi, the equivalent dipole-referenced gain can be determined from:

gain (dBd) = gain (dBi) - 2.15 dB.

If necessary, the antenna gain can be calculated from calibrated antenna factor information

14. Provide the complete measurement results as a part of the test report.

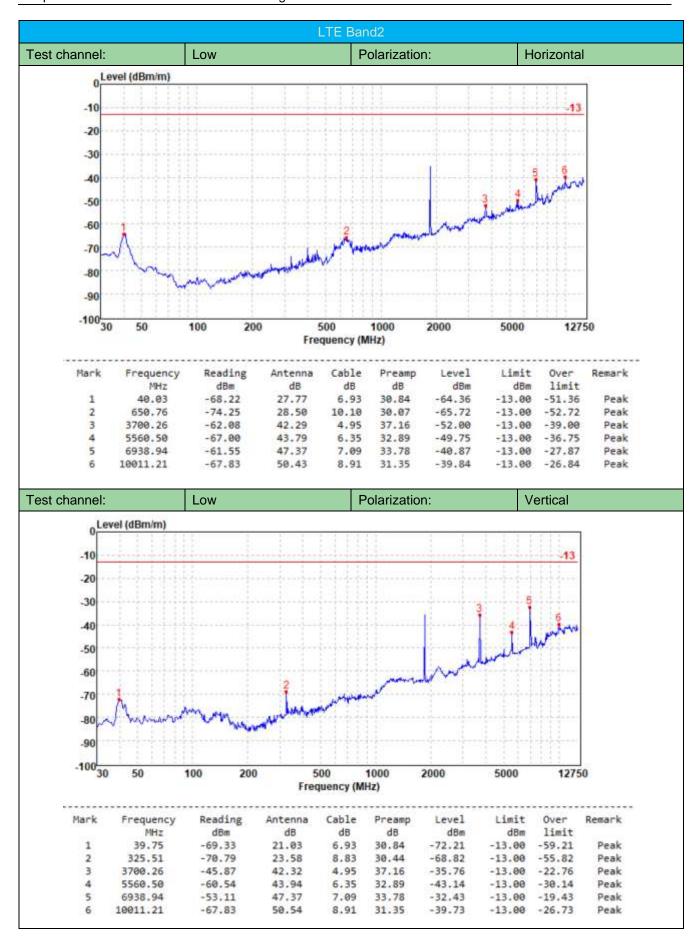
TEST MODE:

Please refer to the clause 4.2

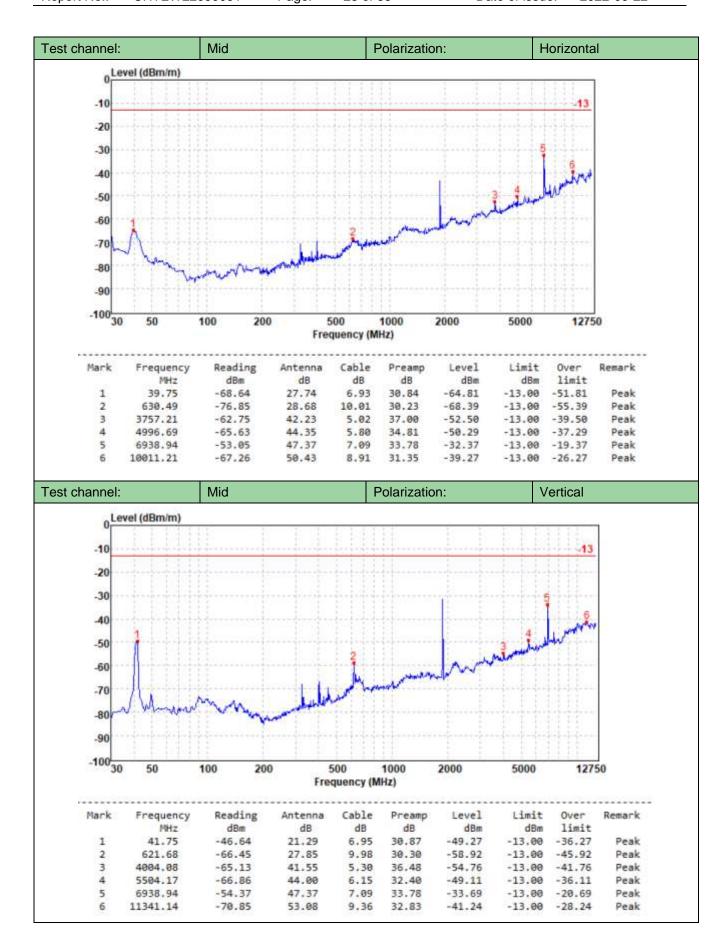
TEST RESULTS

Note: only show the worse case for QPSK modulation.

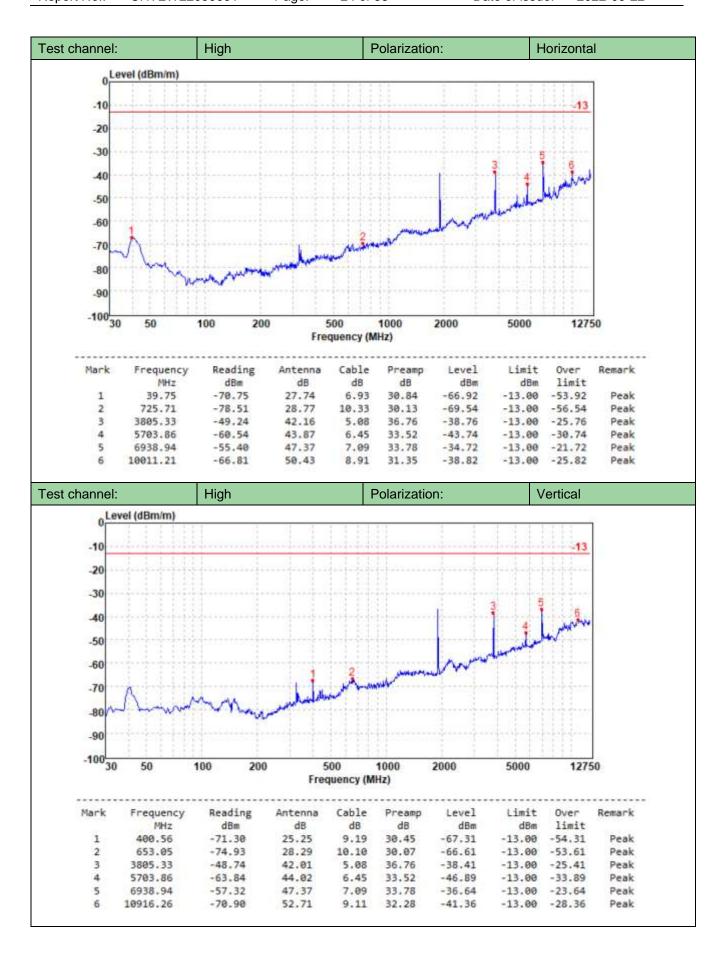
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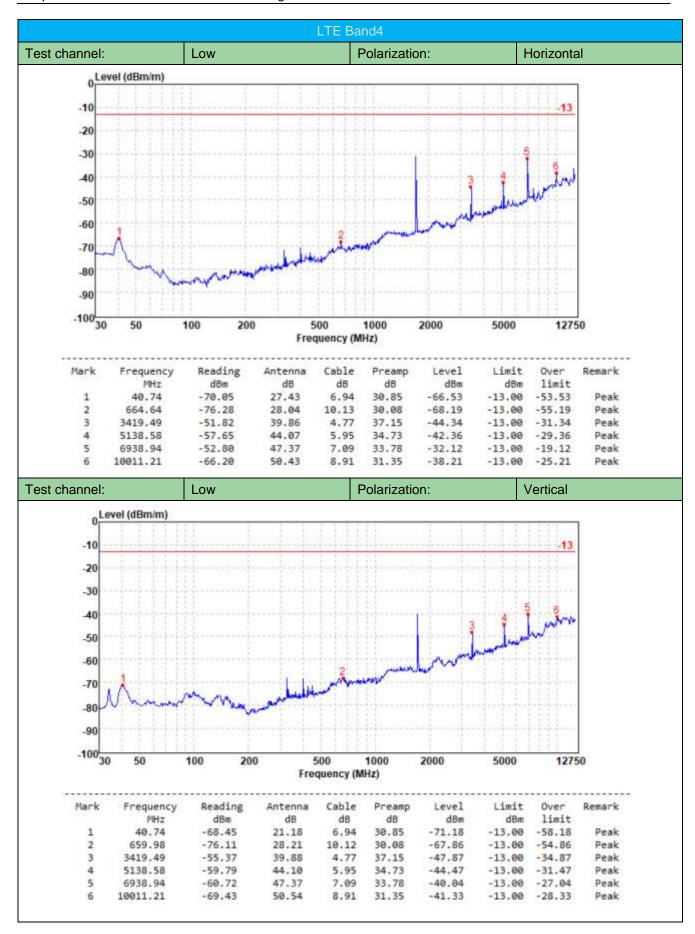
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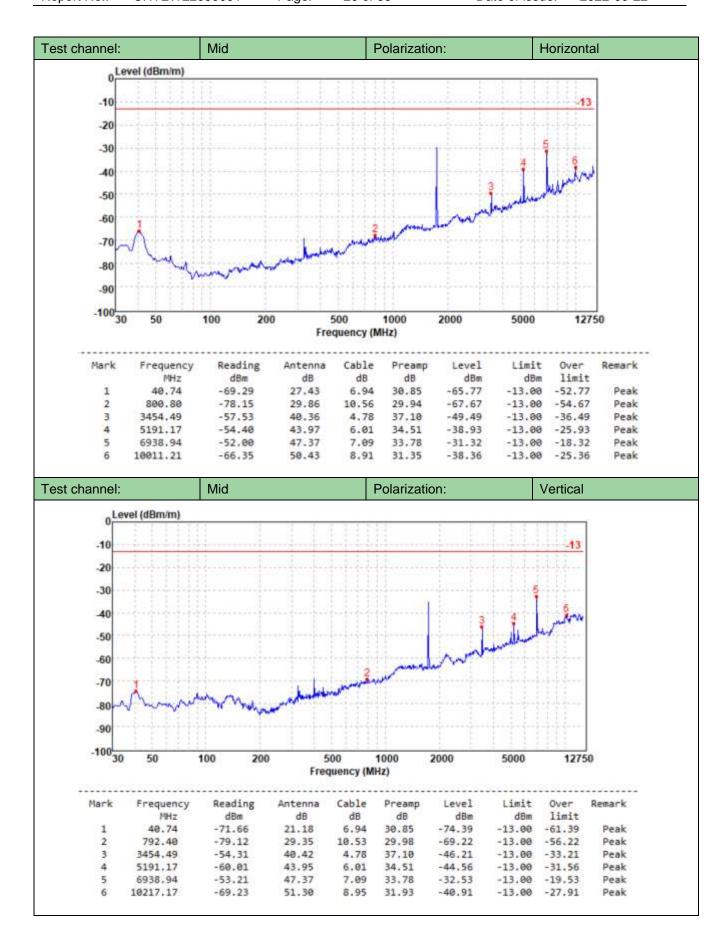
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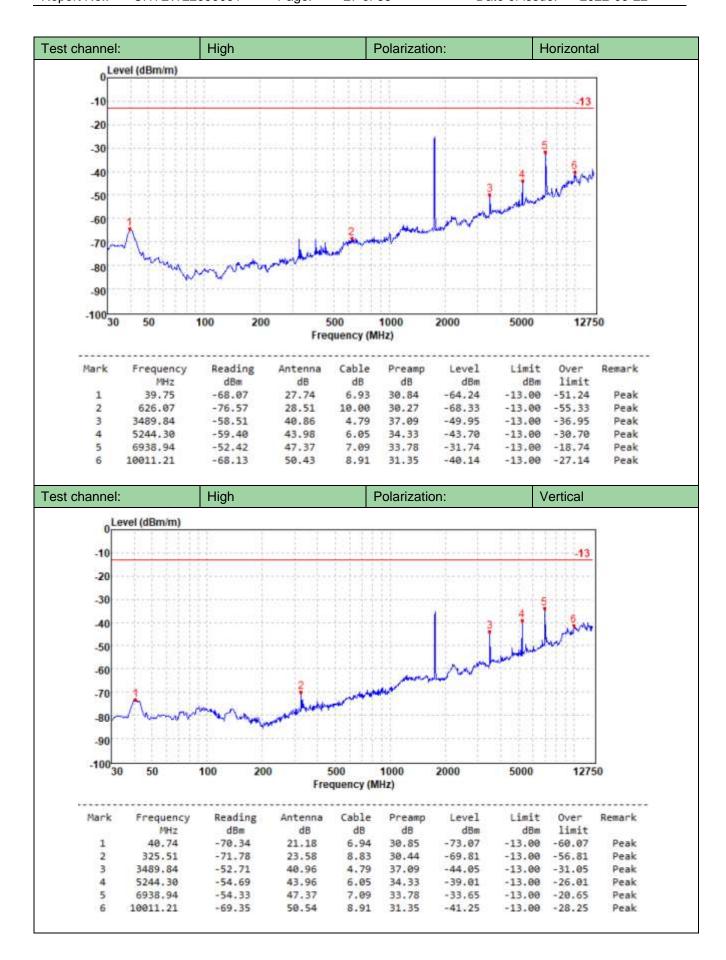
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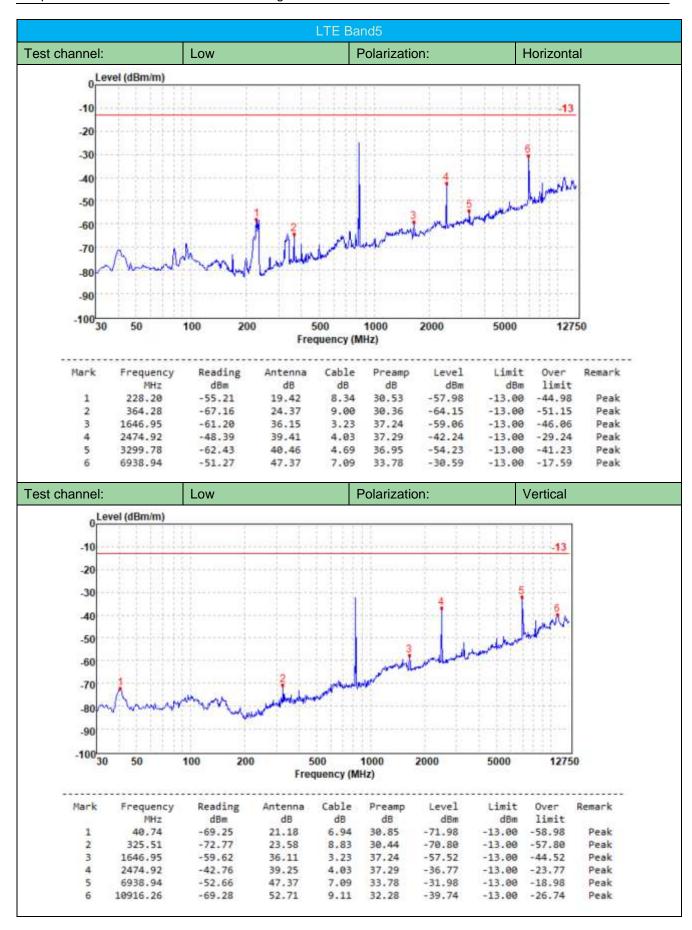
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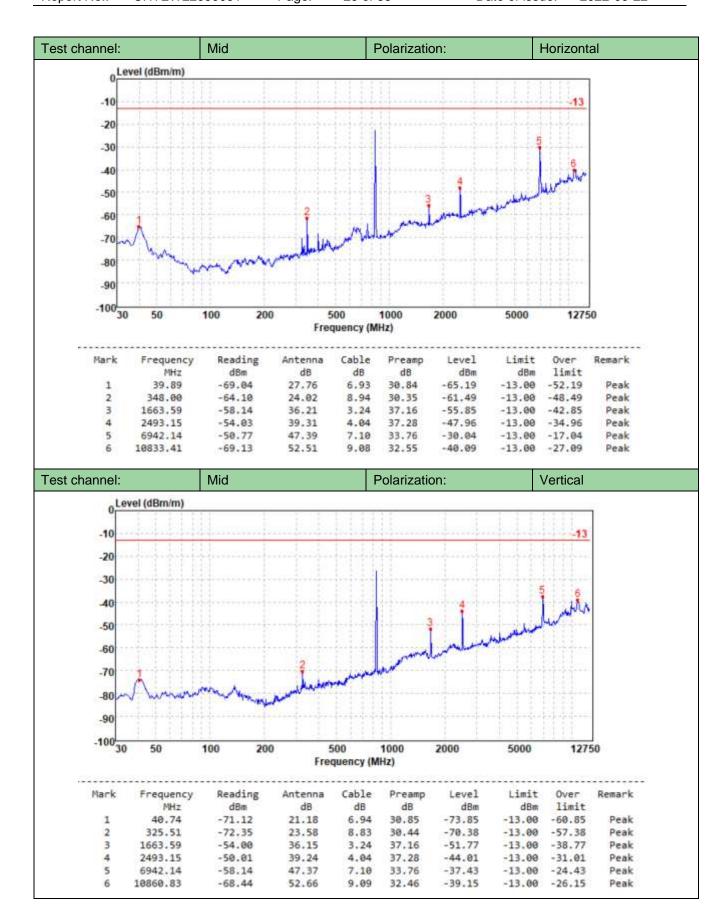
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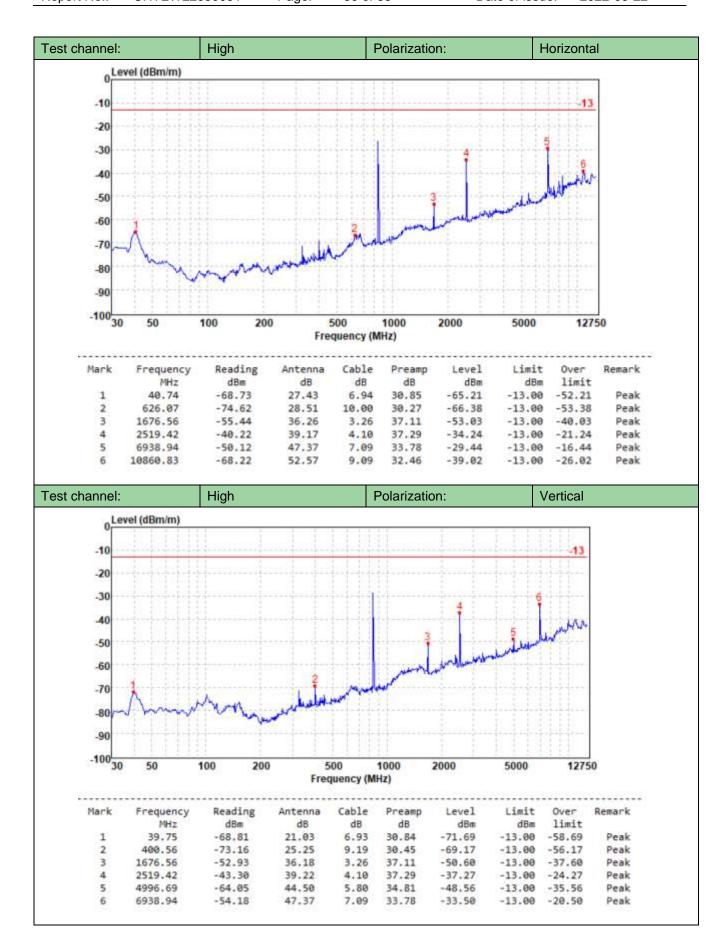
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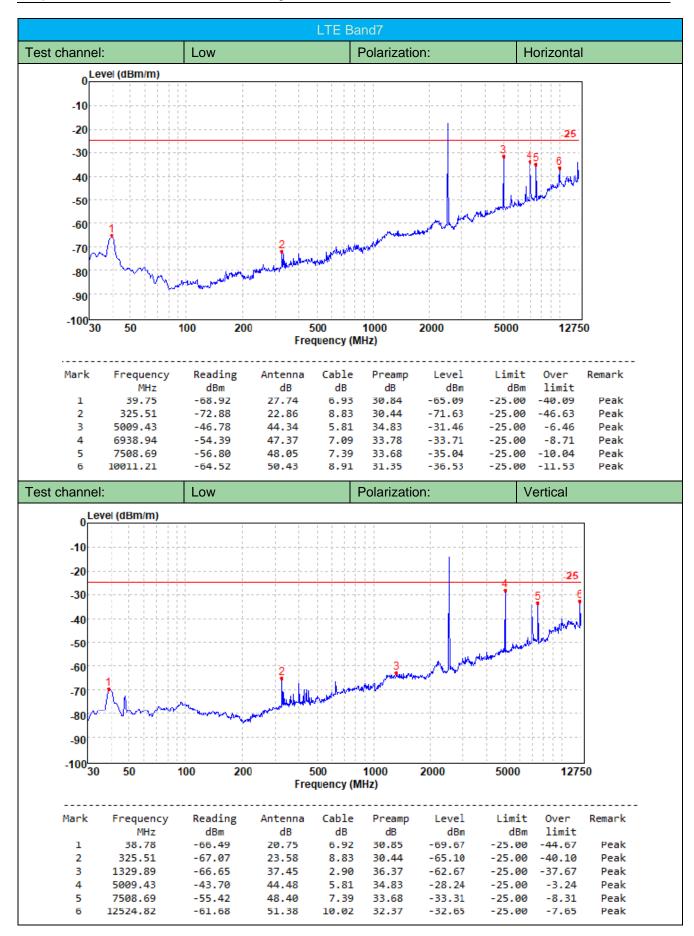
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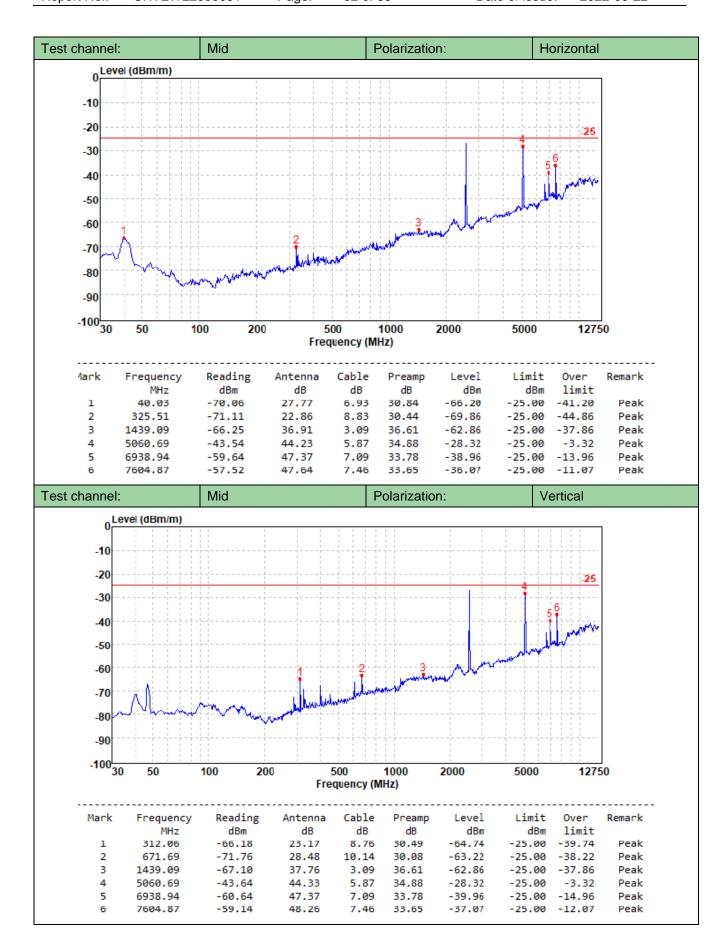
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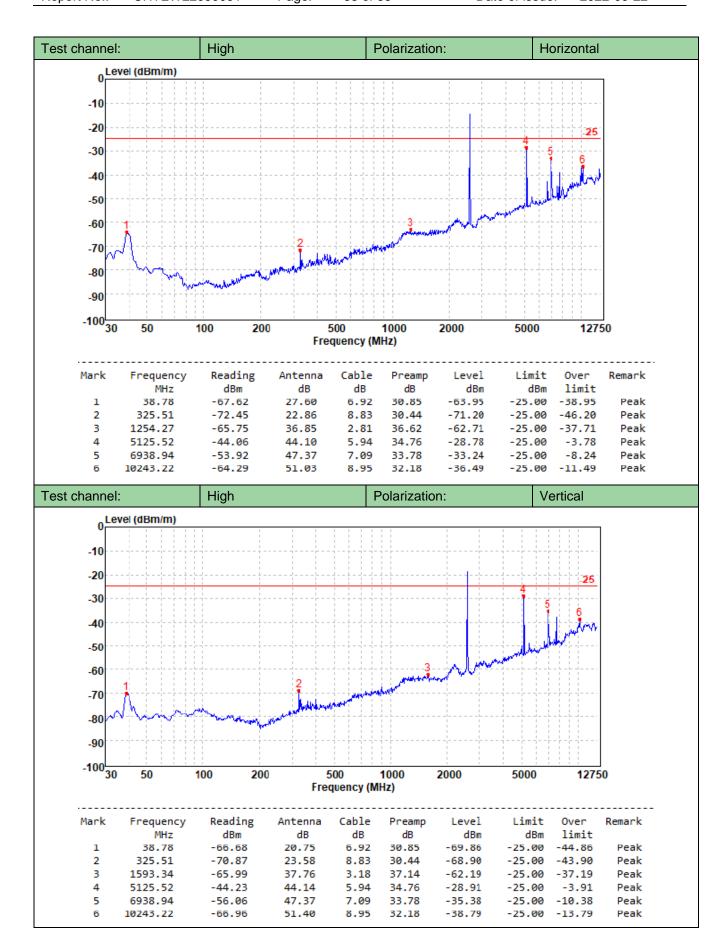
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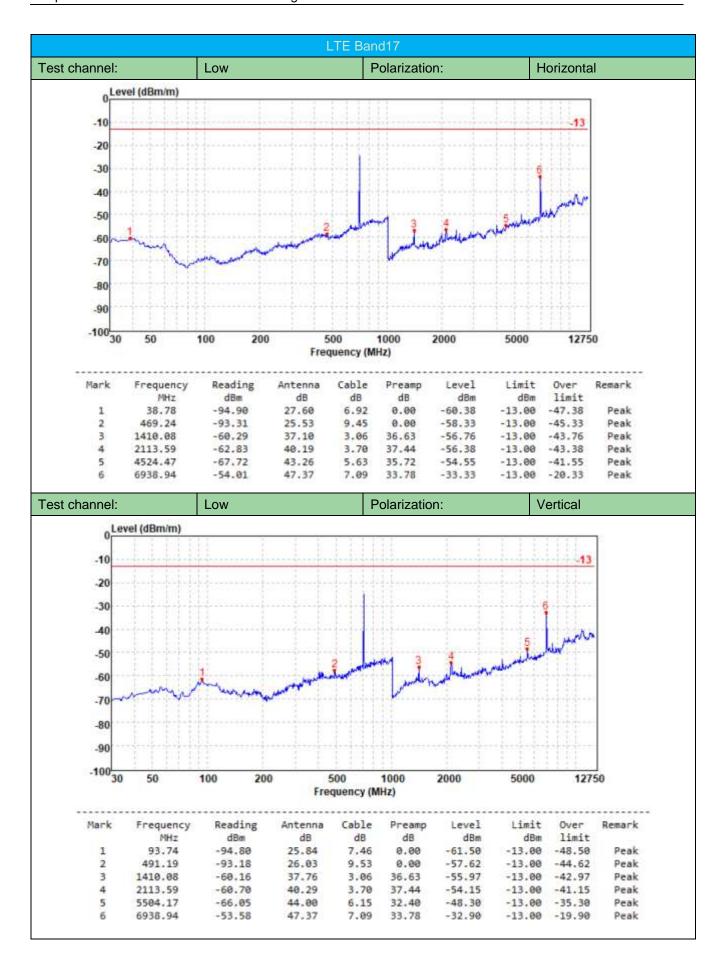
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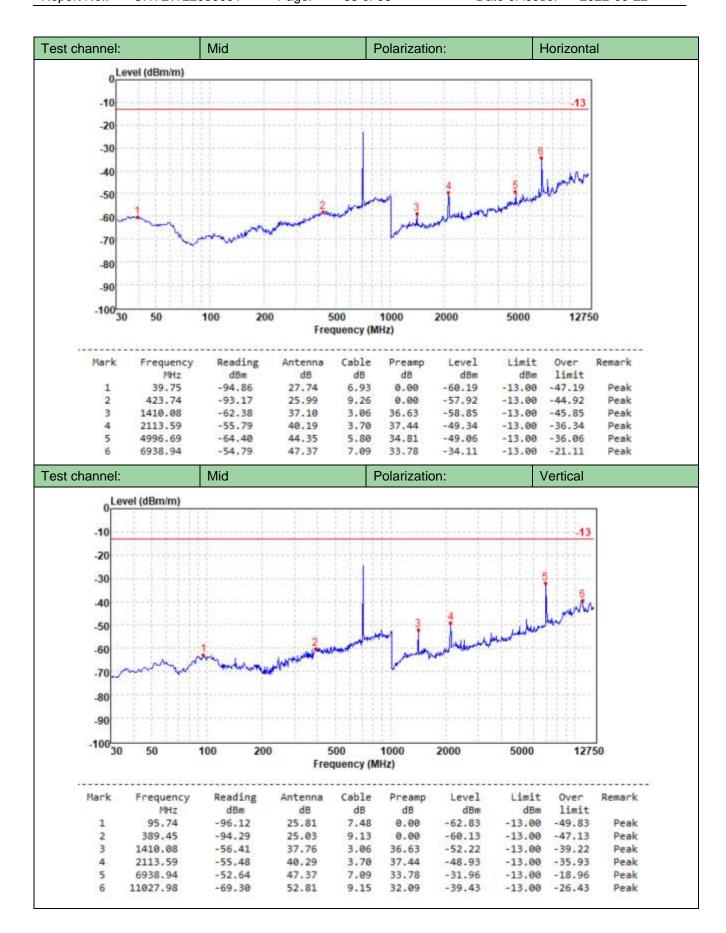
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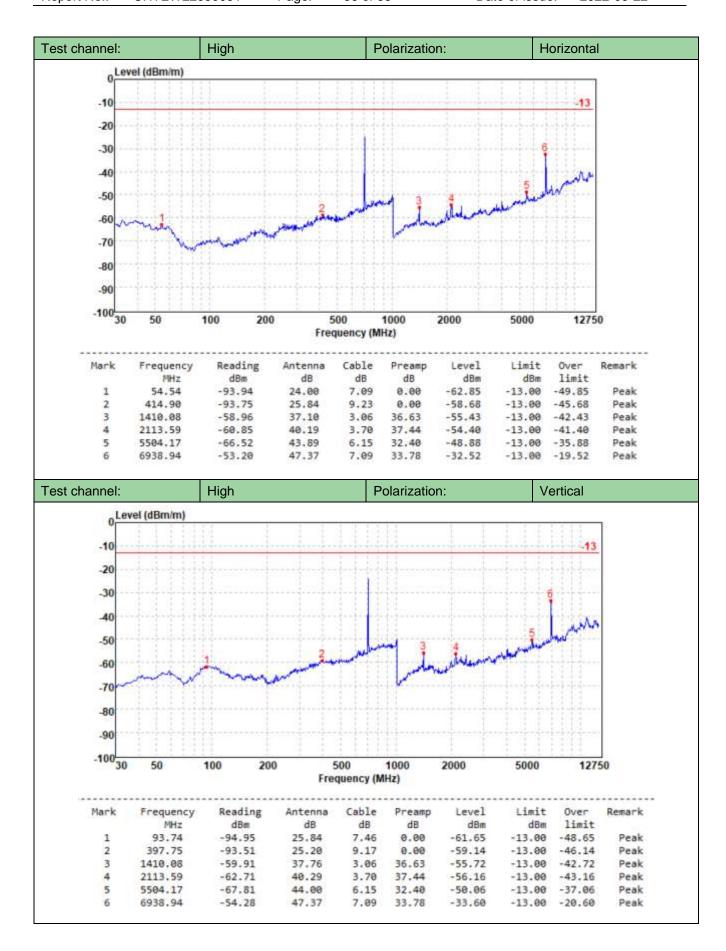
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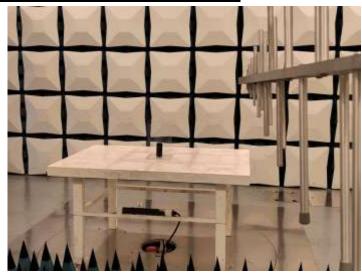


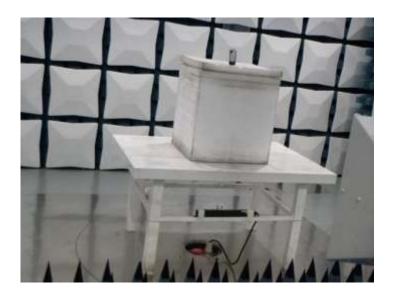
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6. TEST SETUP PHOTOS OF THE EUT







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7. EXTERNAL AND INTERNAL PHOTOS OF THE EUT

Refer to the test report No.: CHTEW22090089

8. APPENDIX REPORT